 arch N	

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/575,864	INADATE, TOSHIO	
Examiner	Art Unit	
Tongoc Tran	2134	

SEARCHED				
Class	Subclass	.Date	Examiner	
726	4- 7,12,17,21	7/15/2007	тт	
705	26,27,80	7/15/2007	TT ·	
	•			
	· -			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
726	3-7	7/15/2007	тт	
705	26,27,80	7/15/2007	TT	
	•			

SEARCH (INCLUDING SEAI	NOT RCH	ES STRATEGY)
		DATE	EXMR
East		7/15/2007	тт
Inventor name search		7/15/2007	тт
ACM		7/15/2007	тт .
•		·	
	,		